

# G3R30MT12J

## 1200 V 30 mΩ SiC MOSFET



### Silicon Carbide MOSFET N-Channel Enhancement Mode

$V_{DS}$	=	1200 V
$R_{DS(ON)}(Typ.)$	=	30 mΩ
$I_D (T_C = 100^\circ C)$	=	55 A

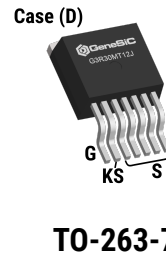
#### Features

- G3R™ SiC MOSFET Technology
- Superior  $Q_G \times R_{DS(ON)}$  Figure of Merit
- Low Capacitances and Low Gate Charge
- Normally-Off Stable Operation up to 175°C
- Fast and Reliable Body Diode
- High Avalanche and Short Circuit Ruggedness
- Low Conduction Losses at High Temperatures
- Optimized Package with Separate Driver Source Pin

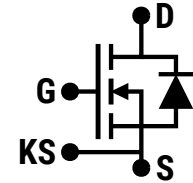
#### Advantages

- Increased Power Density for Compact System
- High Frequency Switching
- Reduced Losses for Higher System Efficiency
- Minimized Gate Ringing
- Improved Thermal Capabilities
- High Cost-Performance Index
- Ease of Paralleling without Thermal Runaway
- Simple to Drive

#### Package



T0-263-7



D = Drain  
G = Gate  
S = Source  
KS = Kelvin Source



#### Applications

- Solar Inverters
- Motor Drives
- EV Charging
- High Voltage DC-DC Converters
- Switched Mode Power Supplies
- UPS
- Smart Grid Transmission and Distribution
- Induction Heating and Welding

#### Absolute Maximum Ratings (At $T_C = 25^\circ C$ Unless Otherwise Stated)

Parameter	Symbol	Conditions	Values	Unit	Note
Drain-Source Voltage	$V_{DS(max)}$	$V_{GS} = 0 V, I_D = 100 \mu s$	1200	V	
Gate-Source Voltage (Dynamic)	$V_{GS(max)}$		-10 / +25	V	
Gate-Source Voltage (Static)	$V_{GS(op)}$	Recommended Operation	-5 / +20	V	
Continuous Forward Current	$I_D$	$T_C = 100^\circ C, V_{GS} = 20 V$	55	A	Fig. 15
		$T_C = 135^\circ C, V_{GS} = 20 V$	40	A	
Pulsed Drain Current	$I_{D(pulse)}$	$t_P \leq 10 \mu s, D \leq 1\%, \text{Note 1}$	200	A	Fig. 14
Power Dissipation	$P_D$	$T_C = 25^\circ C$	285	W	Fig. 16
Operating and Storage Temperature	$T_j, T_{stg}$		-55 to 175	$^\circ C$	

#### Thermal/Package Characteristics

Parameter	Symbol	Conditions	Values			Unit	Note
			Min.	Typ.	Max.		
Thermal Resistance, Junction - Case	$R_{thJC}$			0.53		$^\circ C/W$	Fig. 13
Weight	$W_T$			1.45		g	

Note 1: Pulse Width  $t_P$  Limited by  $T_{j(max)}$

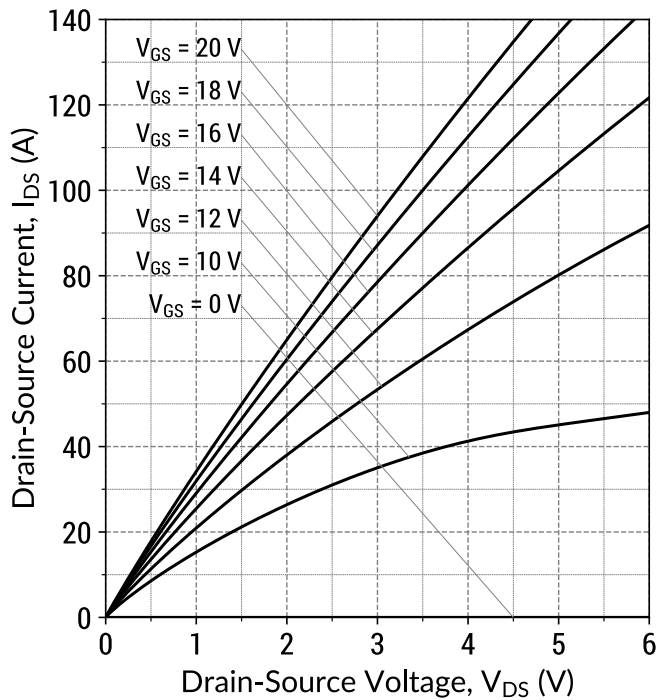
**Electrical Characteristics** (At  $T_c = 25^\circ\text{C}$  Unless Otherwise Stated)

Parameter	Symbol	Conditions	Values			Unit	Note
			Min.	Typ.	Max.		
Drain-Source Breakdown Voltage	$V_{DS}$	$V_{GS} = 0\text{ V}, I_D = 100\text{ }\mu\text{A}$	1200			V	
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = 1200\text{ V}, V_{GS} = 0\text{ V}$		1		$\mu\text{A}$	
Gate Source Leakage Current	$I_{GSS}$	$V_{DS} = 0\text{ V}, V_{GS} = 25\text{ V}$			100	nA	
		$V_{DS} = 0\text{ V}, V_{GS} = -10\text{ V}$			-100		
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 12.0\text{ mA}$	2.3	3.0	4.0	V	Fig. 9
		$V_{DS} = V_{GS}, I_D = 12.0\text{ mA}, T_j = 175^\circ\text{C}$		2.1			
Transconductance	$g_{fs}$	$V_{DS} = 10\text{ V}, I_D = 50\text{ A}$		23.9		S	Fig. 4
		$V_{DS} = 10\text{ V}, I_D = 50\text{ A}, T_j = 175^\circ\text{C}$		20.7			
Drain-Source On-State Resistance	$R_{DS(on)}$	$V_{GS} = 20\text{ V}, I_D = 50\text{ A}$		30	36	mΩ	Fig. 5-8
		$V_{GS} = 20\text{ V}, I_D = 50\text{ A}, T_j = 175^\circ\text{C}$		46			
Input Capacitance	$C_{iss}$	$V_{DS} = 800\text{ V}, V_{GS} = 0\text{ V}$ $f = 1\text{ MHz}, V_{AC} = 25\text{ mV}$		2633		pF	Fig. 11
Output Capacitance	$C_{oss}$			189			
Reverse Transfer Capacitance	$C_{rss}$			16.7			
$C_{oss}$ Stored Energy	$E_{oss}$			115		$\mu\text{J}$	Fig. 12
$C_{oss}$ Stored Charge	$Q_{oss}$	$V_{DS} = 800\text{ V}, V_{GS} = -5 / +20\text{ V}$ $I_D = 50\text{ A}$ Per IEC607478-4		231		nC	
Gate-Source Charge	$Q_{gs}$			30		nC	Fig. 10
Gate-Drain Charge	$Q_{gd}$			48			
Total Gate Charge	$Q_g$			137			
Internal Gate Resistance	$R_{G(int)}$	$f = 1\text{ MHz}, V_{AC} = 25\text{ mV}$		1.7		Ω	

**Reverse Diode Characteristics**

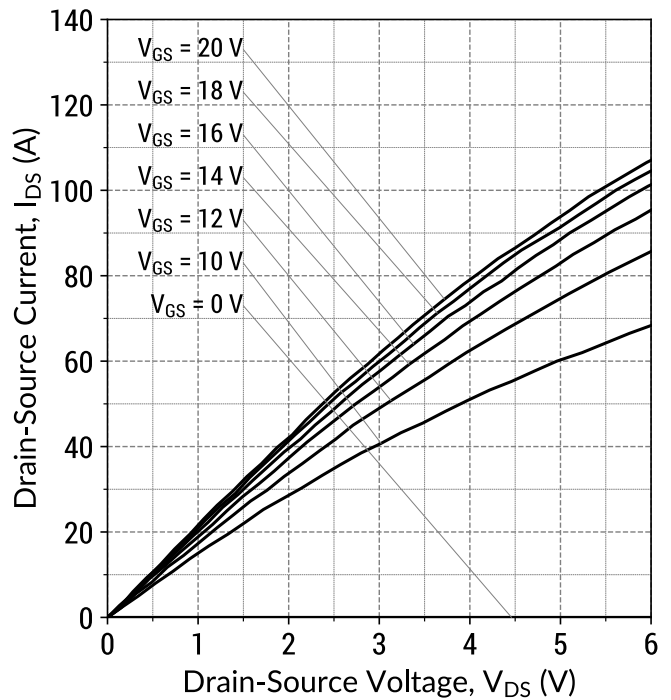
Parameter	Symbol	Conditions	Values			Unit	Note
			Min.	Typ.	Max.		
Diode Forward Voltage	$V_{SD}$	$V_{GS} = -5\text{ V}, I_{SD} = 25\text{ A}$		4.5		V	Fig. 17-18
		$V_{GS} = -5\text{ V}, I_{SD} = 25\text{ A}, T_j = 175^\circ\text{C}$		4.0			
Continuous Diode Forward Current	$I_S$	$V_{GS} = -5\text{ V}, T_c = 100^\circ\text{C}$		29		A	
Diode Pulse Current	$I_{S(pulse)}$	$V_{GS} = -5\text{ V}, \text{Note 1}$		200		A	

**Figure 1: Output Characteristics ( $T_j = 25^\circ\text{C}$ )**



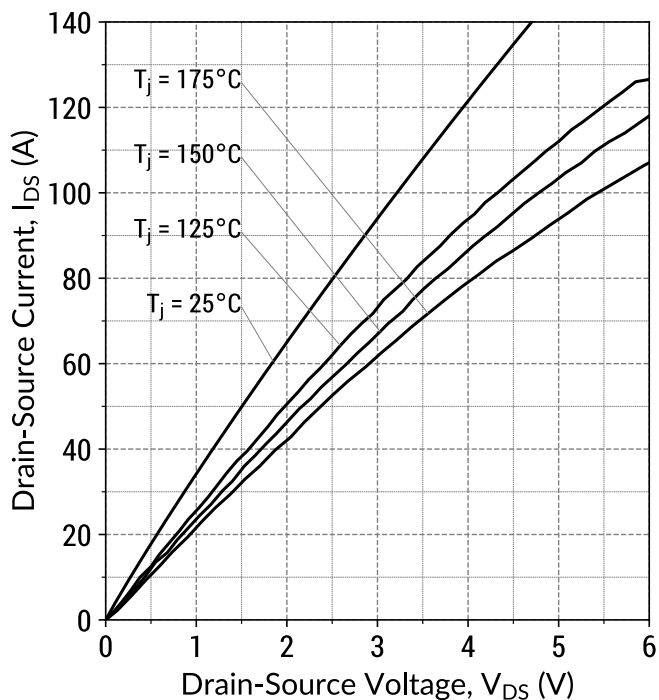
$$I_D = f(V_{DS}, V_{GS}); t_P = 250\ \mu\text{s}$$

**Figure 2: Output Characteristics ( $T_j = 175^\circ\text{C}$ )**



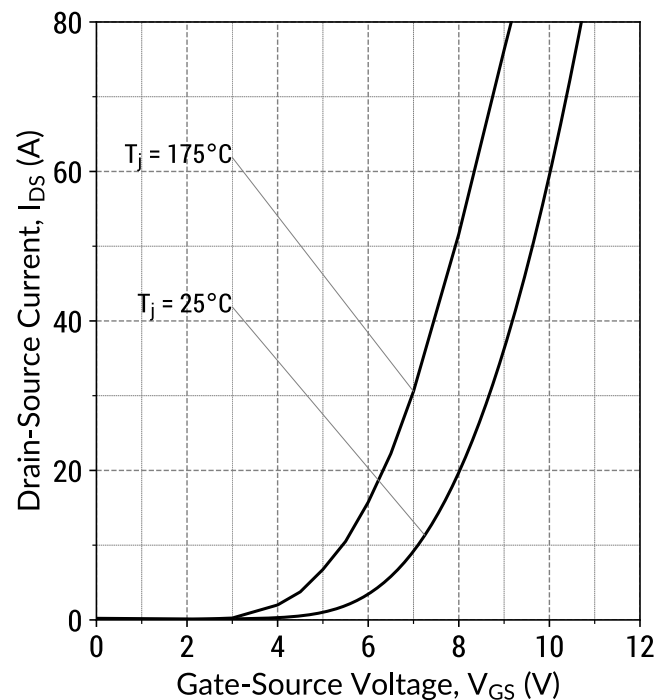
$$I_D = f(V_{DS}, V_{GS}); t_P = 250\ \mu\text{s}$$

**Figure 3: Output Characteristics ( $V_{GS} = 20\text{ V}$ )**



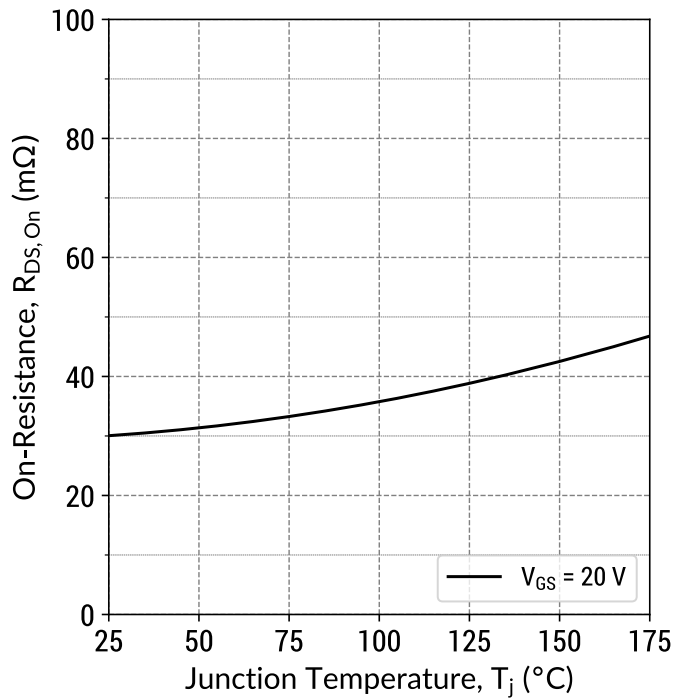
$$I_D = f(V_{DS}, T_j); t_P = 250\ \mu\text{s}$$

**Figure 4: Transfer Characteristics ( $V_{DS} = 10\text{ V}$ )**



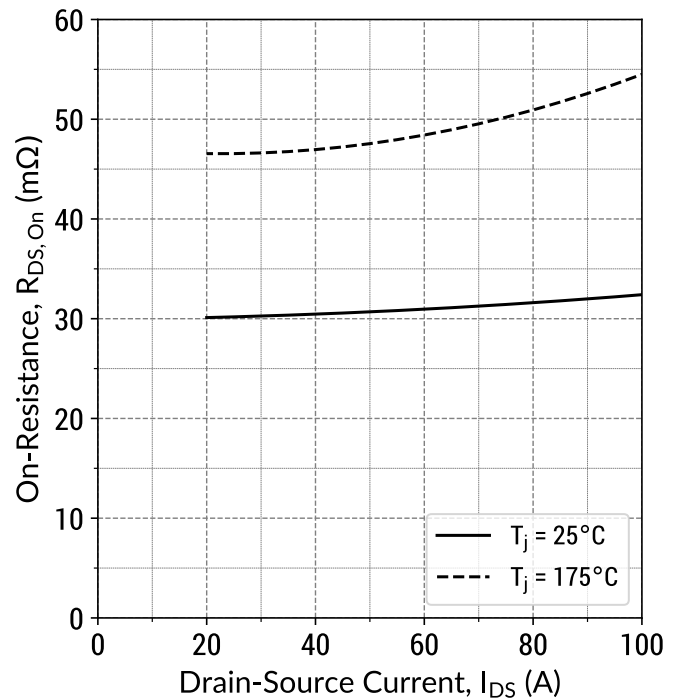
$$I_D = f(V_{GS}, T_j); t_P = 100\ \mu\text{s}$$

**Figure 5: On-State Resistance v/s Temperature**



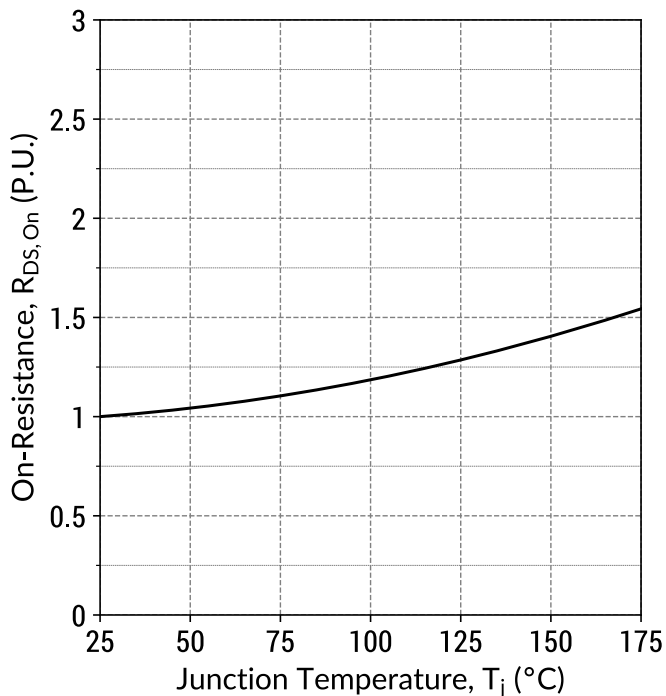
$$R_{DS(ON)} = f(T_j, V_{GS}); t_P = 250 \mu s; I_D = 50 A$$

**Figure 6: On-State Resistance v/s Drain Current**



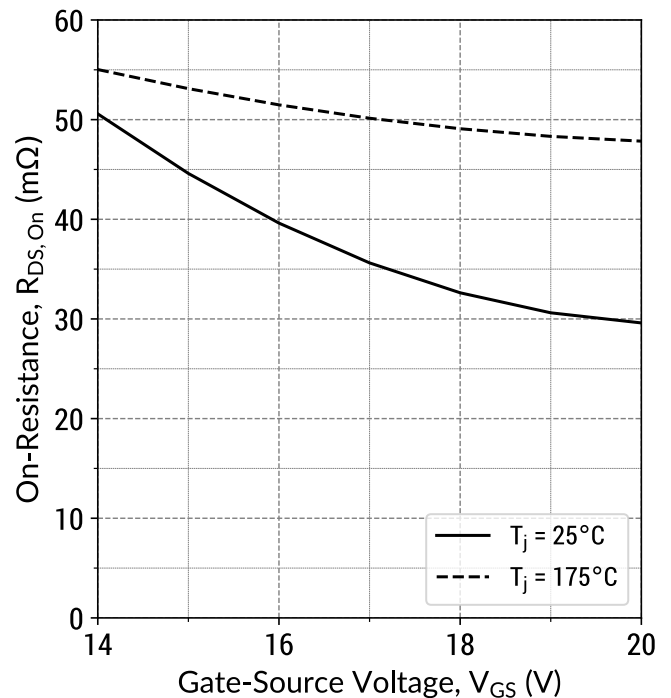
$$R_{DS(ON)} = f(T_j, I_D); t_P = 250 \mu s; V_{GS} = 20 V$$

**Figure 7: Normalized On-State Resistance v/s Temperature**



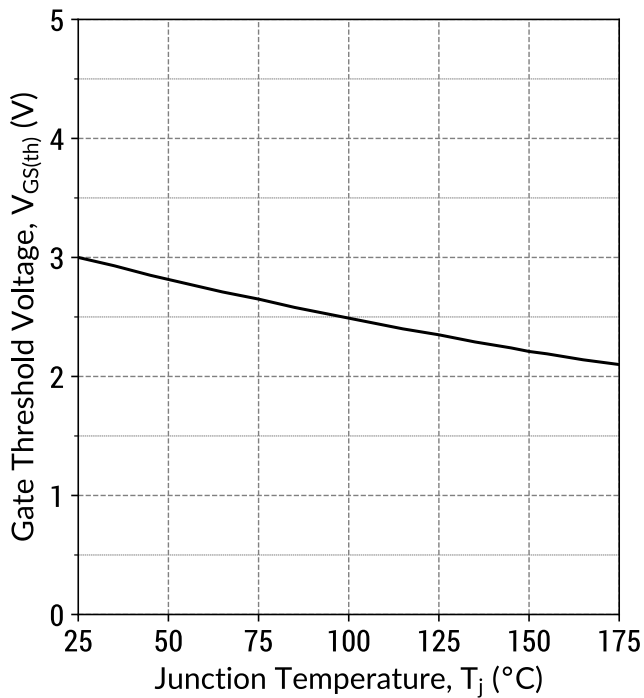
$$R_{DS(ON)} = f(T_j); t_P = 250 \mu s; I_D = 50 A; V_{GS} = 20 V$$

**Figure 8: On-State Resistance v/s Gate Voltage**



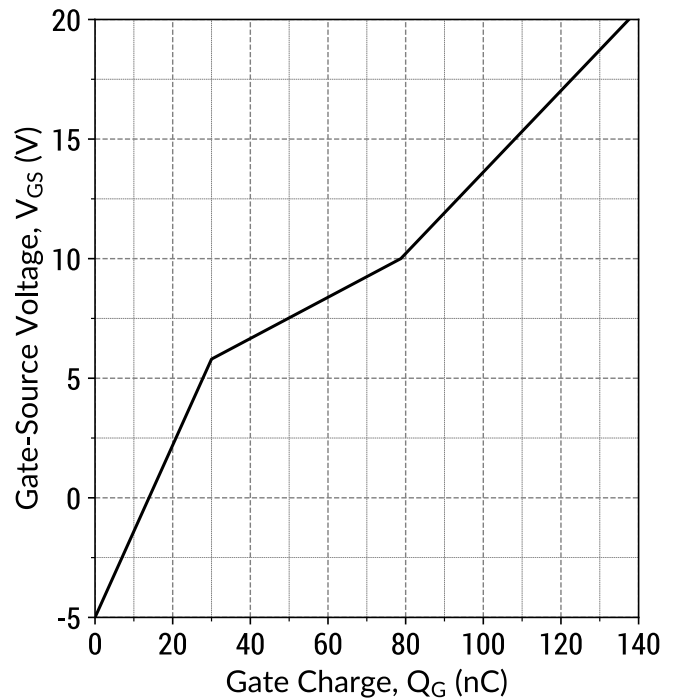
$$R_{DS(ON)} = f(T_j, V_{GS}); t_P = 250 \mu s; I_D = 50 A$$

**Figure 9: Threshold Voltage Characteristics**



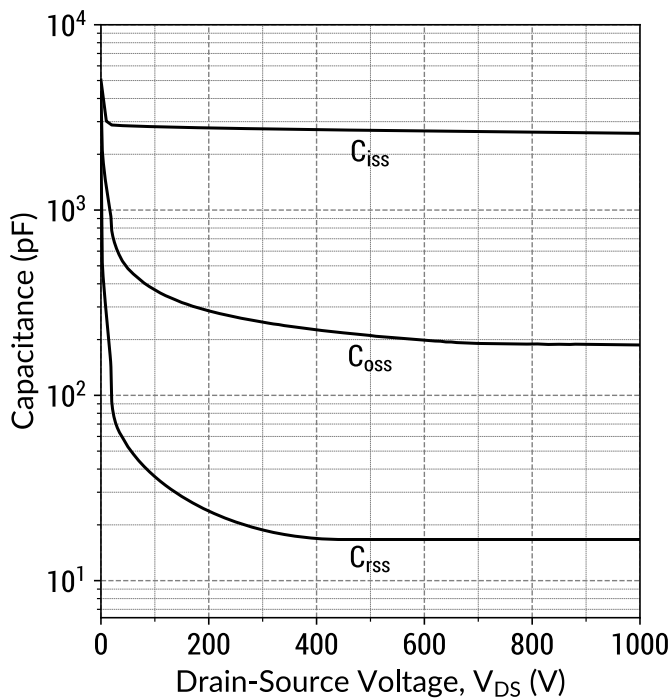
$V_{GS(th)} = f(T_J); V_{DS} = V_{GS}; I_D = 12.0 \text{ mA}$

**Figure 10: Gate Charge Characteristics**



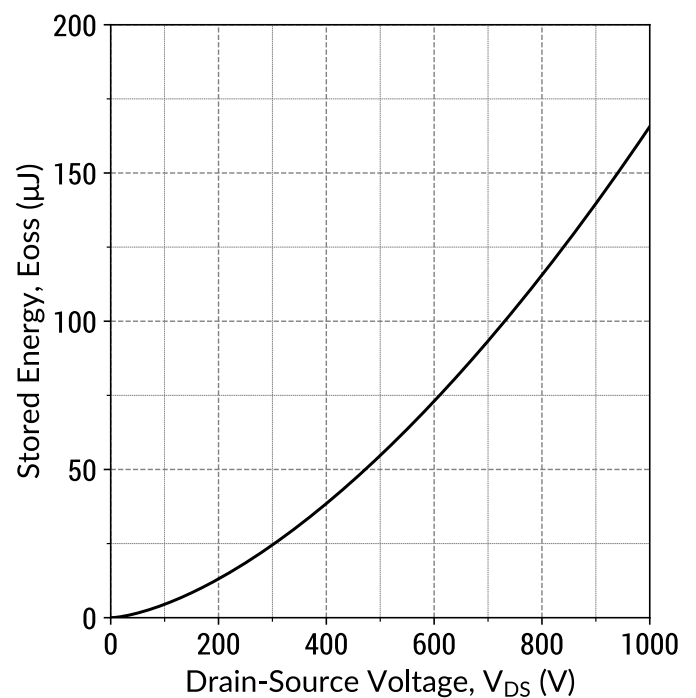
$I_D = 50 \text{ A}; V_{DS} = 800 \text{ V}; T_c = 25^\circ\text{C}$

**Figure 11: Capacitance v/s Drain-Source Voltage**



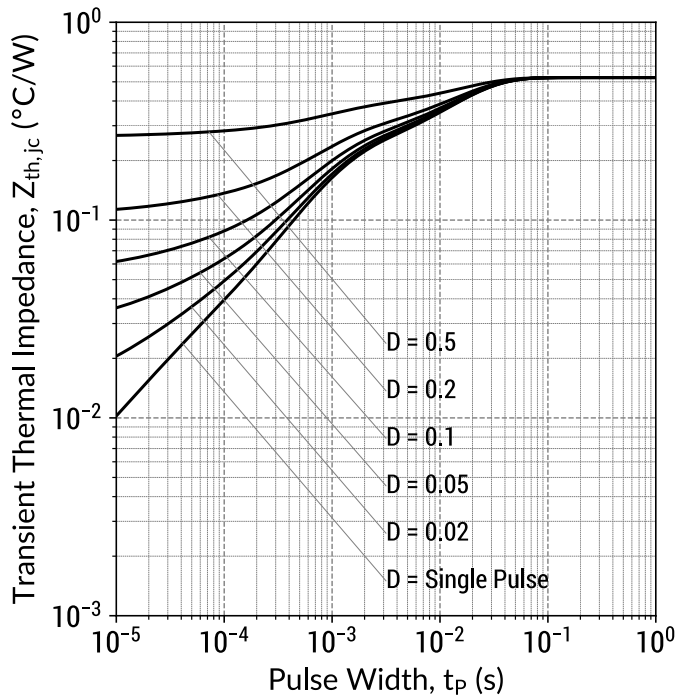
$f = 1 \text{ MHz}; V_{AC} = 25 \text{ mV}$

**Figure 12: Output Capacitor Stored Energy**



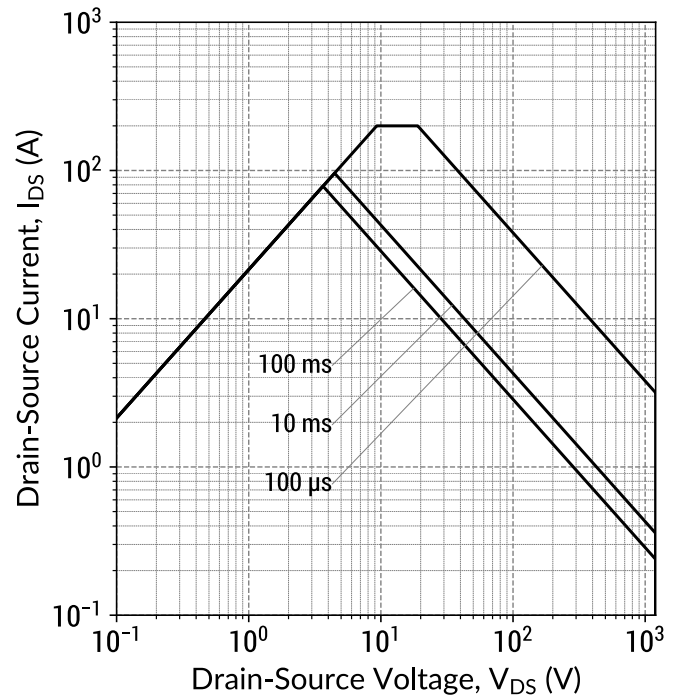
$E_{oss} = f(V_{DS})$

**Figure 13: Transient Thermal Impedance**



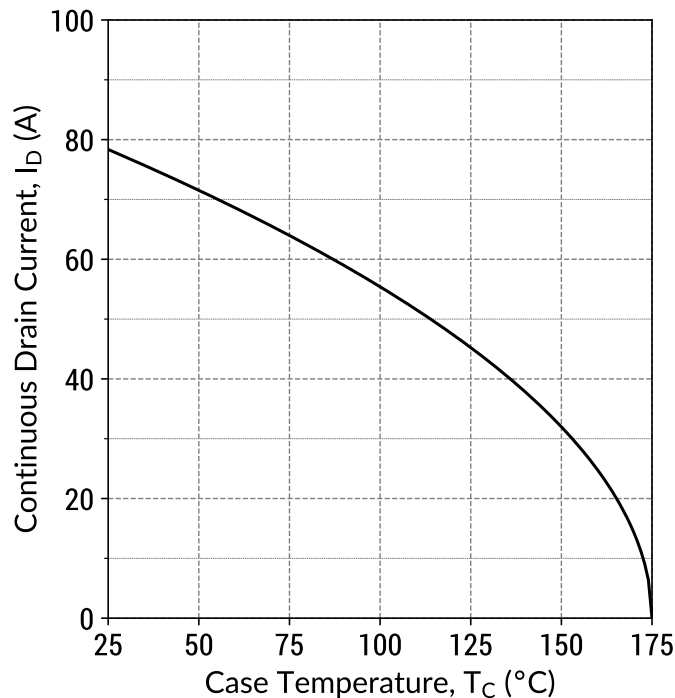
$$Z_{th,jc} = f(t_p, D); D = t_p / T$$

**Figure 14: Safe Operating Area ( $T_c = 25^\circ\text{C}$ )**



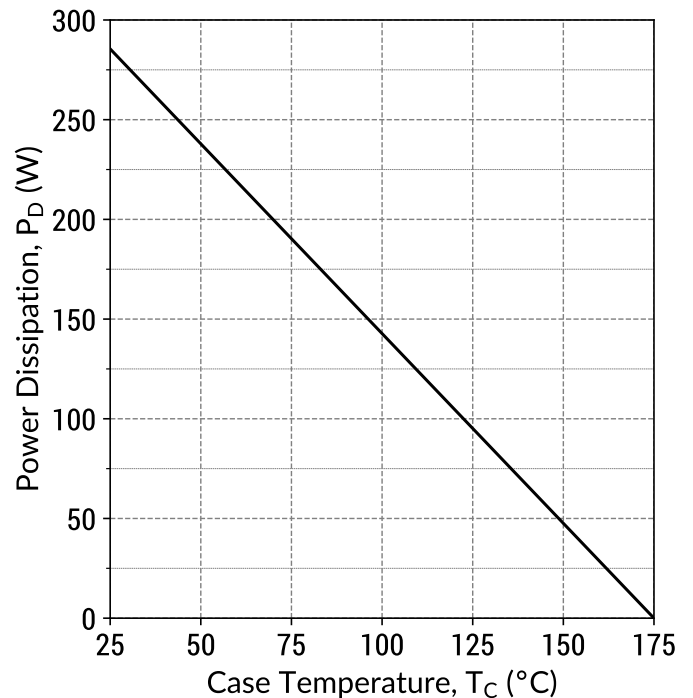
$$I_D = f(V_{DS}, t_p); T_j \leq 175^\circ\text{C}; D = 0$$

**Figure 15: Current De-rating Curve**



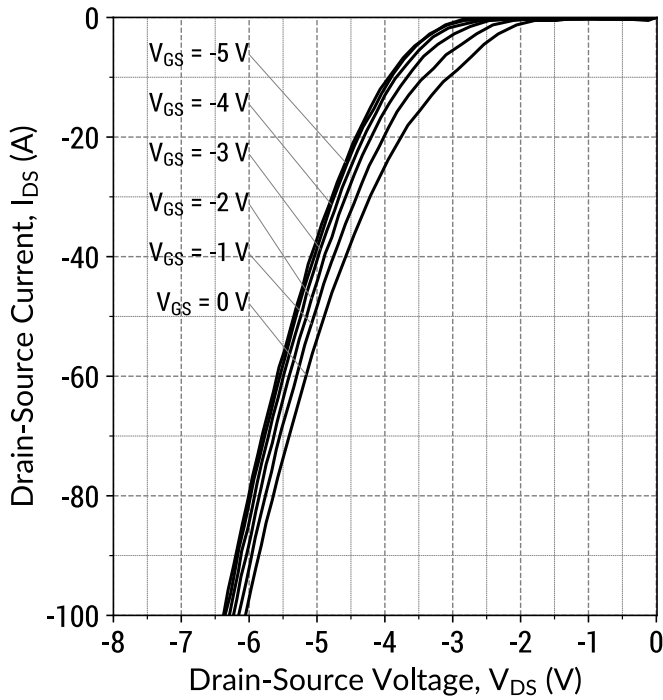
$$I_D = f(T_C); T_j \leq 175^\circ\text{C}$$

**Figure 16: Power De-rating Curve**



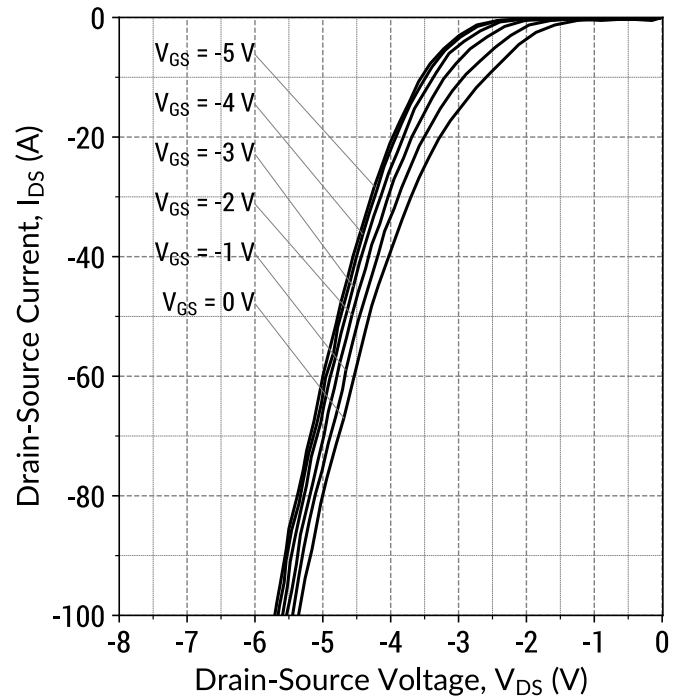
$$P_D = f(T_C); T_j \leq 175^\circ\text{C}$$

**Figure 17: Body Diode Characteristics ( $T_j = 25^\circ\text{C}$ )**



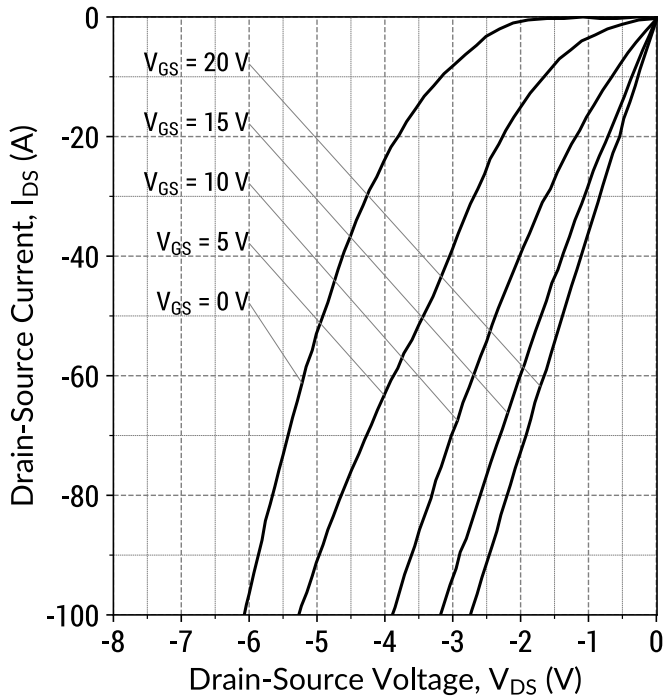
$$I_D = f(V_{DS}, V_{GS}); t_P = 250 \mu\text{s}$$

**Figure 18: Body Diode Characteristics ( $T_j = 175^\circ\text{C}$ )**



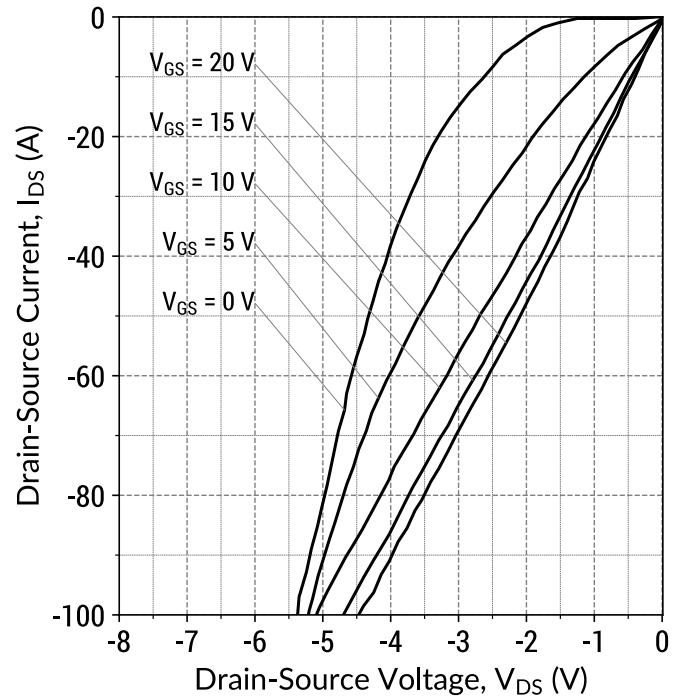
$$I_D = f(V_{DS}, V_{GS}); t_P = 250 \mu\text{s}$$

**Figure 19: Third Quadrant Characteristics ( $T_j = 25^\circ\text{C}$ )**



$$I_D = f(V_{DS}, V_{GS}); t_P = 250 \mu\text{s}$$

**Figure 20: Third Quadrant Characteristics ( $T_j = 175^\circ\text{C}$ )**

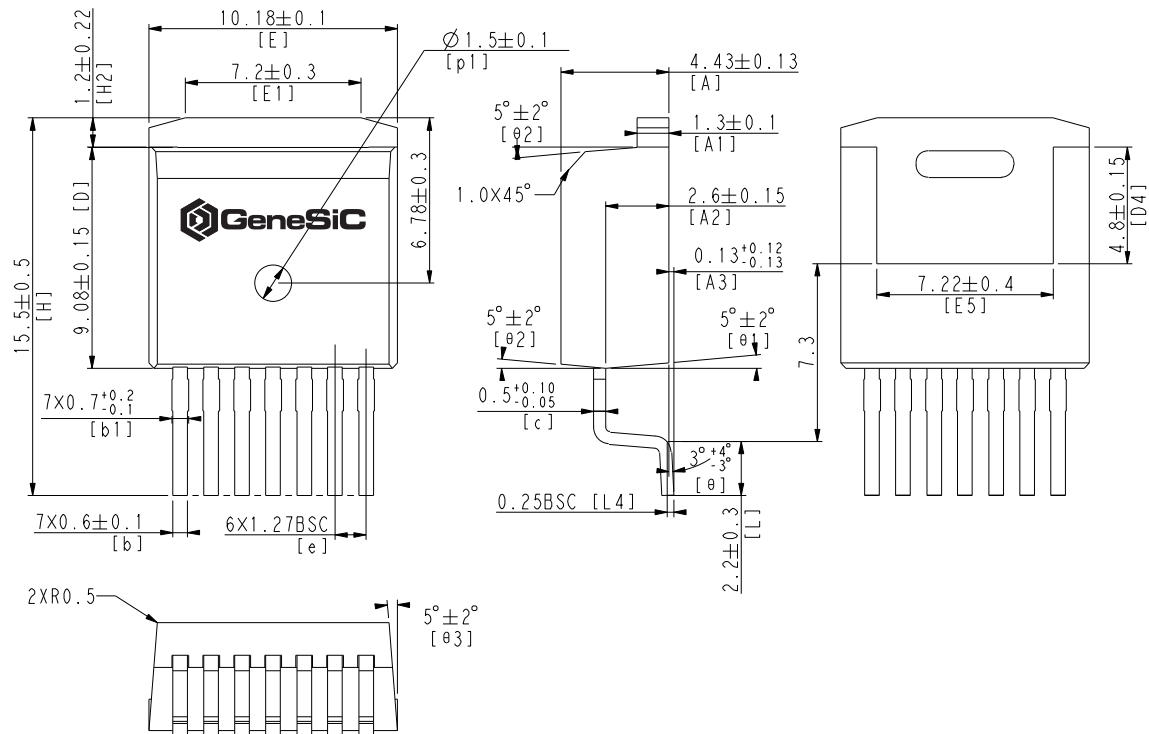


$$I_D = f(V_{DS}, V_{GS}); t_P = 250 \mu\text{s}$$

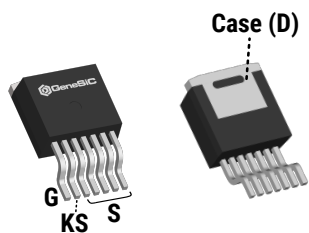


## Package Dimensions

### TO-263-7 Package Outline



### Package View



#### NOTE

1. CONTROLLED DEIMENSION IS INCH. DIMENSION IN BRACKET IS MILLIMETER.
2. DIMENSIONS DO NOT INCLUDE END FLASH, MOLD FLASH, MATERIAL PROTRUSIONS.



### RoHS Compliance

The levels of RoHS restricted materials in this product are below the maximum concentration values (also referred to as the threshold limits) permitted for such substances, or are used in an exempted application, in accordance with EU Directive 2011/65/EC (RoHS 2), as adopted by EU member states on January 2, 2013 and amended on March 31, 2015 by EU Directive 2015/863. RoHS Declarations for this product can be obtained from your GeneSiC representative.

### REACH Compliance

REACH substances of high concern (SVHCs) information is available for this product. Since the European Chemical Agency (ECHA) has published notice of their intent to frequently revise the SVHC listing for the foreseeable future, please contact a GeneSiC representative to insure you get the most up-to-date REACH SVHC Declaration. REACH banned substance information (REACH Article 67) is also available upon request.

This product has not been designed or tested for use in, and is not intended for use in, applications implanted into the human body nor in applications in which failure of the product could lead to death, personal injury or property damage, including but not limited to equipment used in the operation of nuclear facilities, life-support machines, cardiac defibrillators or similar emergency medical equipment, aircraft navigation or communication or control systems, or air traffic control systems.

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### Related Links

- SPICE Models: [https://www.genesicsemi.com/sic-mosfet/G3R30MT12J/G3R30MT12J\\_SPICE.zip](https://www.genesicsemi.com/sic-mosfet/G3R30MT12J/G3R30MT12J_SPICE.zip)
- PLECS Models: [https://www.genesicsemi.com/sic-mosfet/G3R30MT12J/G3R30MT12J\\_PLECS.zip](https://www.genesicsemi.com/sic-mosfet/G3R30MT12J/G3R30MT12J_PLECS.zip)
- CAD Models: [https://www.genesicsemi.com/sic-mosfet/G3R30MT12J/G3R30MT12J\\_3D.zip](https://www.genesicsemi.com/sic-mosfet/G3R30MT12J/G3R30MT12J_3D.zip)
- Gate Driver Reference: <https://www.genesicsemi.com/technical-support>
- Evaluation Boards: <https://www.genesicsemi.com/technical-support>
- Reliability: <https://www.genesicsemi.com/reliability>
- Compliance: <https://www.genesicsemi.com/compliance>
- Quality Manual: <https://www.genesicsemi.com/quality>

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